

# S-5718 Series

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## LOW VOLTAGE OPERATION OMNIPOLAR / UNIPOLAR DETECTION TYPE HALL EFFECT SWITCH IC WITH SWITCHABLE DETECTION POLE FUNCTION

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Rev.1.1\_01

This IC, developed by CMOS technology, is a high-accuracy Hall effect switch IC with switchable detection pole function that operates at a low voltage and low current consumption.

The output voltage changes when this IC detects the intensity level of magnetic flux density of the polarity according to the input pin status. The inclusion of a switchable detection pole function makes it possible to reduce the number of parts and realize a variety of different systems by using this IC with a magnet. High-density mounting is possible by using the super small SNT-4A package.

Due to its low voltage operation and low current consumption, this IC is suitable for battery-operated portable devices. Its high-accuracy magnetic characteristics also allow this IC to reduce operation dispersion in magnet combination systems.

ABLIC Inc. offers a "magnetic simulation service" that provides the ideal combination of magnets and our Hall effect ICs for customer systems. Our magnetic simulation service will reduce prototype production, development period and development costs. In addition, it will contribute to optimization of parts to realize high cost performance.

For more information regarding our magnetic simulation service, contact our sales office.

### Features

| <ul> <li>Switchable detection pole function:</li> <li>Output logic<sup>*1</sup>:</li> </ul> | Omnipolar detection, S pole detection, N pole detection Active "L" |
|---|--|
| Output former   | Active "H"   |
| Output form:  | CMOS output  |
| <ul> <li>Magnetic sensitivity (hysteresis width)<sup>*1</sup>:</li> </ul>                   | B <sub>OP</sub> = 1.8 mT typ. (В <sub>НУS</sub> = 0.7 mT typ.)     |
|   | $B_{OP}$ = 3.0 mT typ. ( $B_{HYS}$ = 0.8 mT typ.)                  |
|   | B <sub>OP</sub> = 3.0 mT typ. (B <sub>HYS</sub> = 1.3 mT typ.)     |
|   | $B_{OP}$ = 4.5 mT typ. ( $B_{HYS}$ = 1.0 mT typ.)                  |
|   | $B_{OP}$ = 4.5 mT typ. (B <sub>HYS</sub> = 2.5 mT typ.)            |
| <ul> <li>Operating cycle (current consumption)<sup>*1</sup>:</li> </ul>                     | $t_{CYCLE}$ = 102.1 ms typ. (I <sub>DD</sub> = 1.4 µA typ.)        |
|   | $t_{CYCLE}$ = 50.5 ms typ. (I <sub>DD</sub> = 2.0 µA typ.)         |
|   | $t_{CYCLE}$ = 5.7 ms typ. (I <sub>DD</sub> = 12.0 µA typ.)         |
| <ul> <li>Power supply voltage range<sup>*2</sup>:</li> </ul>                                | V <sub>DD</sub> = 1.45 V to 3.6 V                                  |
| <ul> <li>Operation temperature range:</li> </ul>  | $Ta = -40^{\circ}C \text{ to } +85^{\circ}C$                       |

• Lead-free (Sn 100%), halogen-free

\*1. The option can be selected.

**\*2.** Power supply voltage range is different by optional combination.

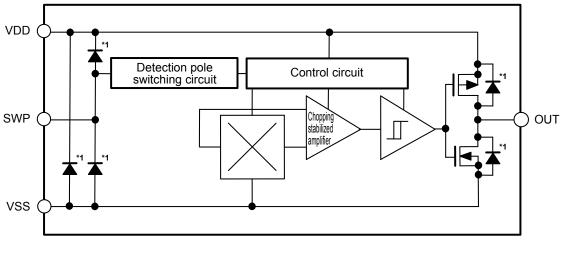
# Applications

- Mobile phone, smart phone
- Notebook PC, tablet PC
- Wearable device
- Plaything, portable game
- Home appliance

#### Package

• SNT-4A

# Block Diagram

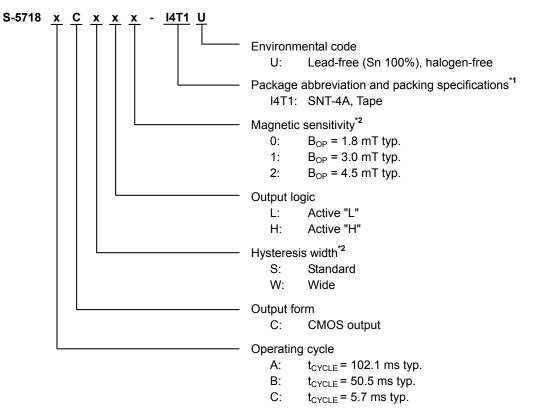


\*1. Parasitic diode

Figure 1

## Product Name Structure

1. Product name



\*1. Refer to the tape drawing.

**\*2.** Magnetic sensitivity and hysteresis width combinations are as follows.

| Magnatia Canaitivity              | Hysteresis Width               |                                |  |  |  |  |
|-----------------------------------|--------------------------------|--------------------------------|--|--|--|--|
| Magnetic Sensitivity              | S (Standard)                   | W (Wide)                       |  |  |  |  |
| 0 (B <sub>OP</sub> = 1.8 mT typ.) | В <sub>НҮЅ</sub> = 0.7 mT typ. | _                              |  |  |  |  |
| 1 (B <sub>OP</sub> = 3.0 mT typ.) | В <sub>НҮЅ</sub> = 0.8 mT typ. | В <sub>НҮЅ</sub> = 1.3 mT typ. |  |  |  |  |
| 2 (B <sub>OP</sub> = 4.5 mT typ.) | В <sub>НҮЅ</sub> = 1.0 mT typ. | В <sub>НҮЅ</sub> = 2.5 mT typ. |  |  |  |  |

#### 2. Package

| Table 1 | Package | Drawing | Codes |
|---------|---------|---------|-------|
|---------|---------|---------|-------|

| Package Name Dimension |              | Tape         | Reel         | Land         |  |
|------------------------|--------------|--------------|--------------|--------------|--|
| SNT-4A                 | PF004-A-P-SD | PF004-A-C-SD | PF004-A-R-SD | PF004-A-L-SD |  |

#### 3. Product name list

Table 2 Magnetic **Operating Cycle** Hysteresis Width Product Name Output Form Output Logic Sensitivity (t<sub>CYCLE</sub>) (BHYS) (B<sub>OP</sub>) S-5718CCWL1-I4T1U Wide (1.3 mT typ.) 3.0 mT typ. 5.7 ms typ. CMOS output Active "L" S-5718CCSH0-I4T1U\*1 Standard (0.7 mT typ.) Active "H" 5.7 ms typ. CMOS output 1.8 mT typ. S-5718CCSL0-I4T1U\*1 CMOS output Standard (0.7 mT typ.) Active "L" 5.7 ms typ. 1.8 mT typ.

\*1. V<sub>DD</sub> = 1.6 V to 3.6 V

**Remark** Please contact our sales office for products other than the above.

# Pin Configuration

#### 1. SNT-4A

| Table 3 |        |  |  |  |  |  |  |  |
|---------|--------|--|--|--|--|--|--|--|
| Pin No. | Symbol | Pin Description                            |  |  |  |  |  |  |
| 1       | VDD    | Power supply pin                           |  |  |  |  |  |  |
| 2       | VSS    | GND pin                                    |  |  |  |  |  |  |
| 3       | SWP    | Detection pole switching pin <sup>*1</sup> |  |  |  |  |  |  |
| 4       | OUT    | Output pin                                 |  |  |  |  |  |  |

\*1. For details, refer to "3. Basic operation" in "
Operation".

# Absolute Maximum Ratings

Top view

Figure 2

1 **o** 2 **c ]**4 3

|                               |                  |                | (Ta = +25°C unless otherwis                    | se specified) |
|-------------------------------|------------------|----------------|--|---------------|
| Item                          | Symbol           | Applicable Pin | Absolute Maximum Rating                        | Unit          |
| Power supply voltage          | V <sub>DD</sub>  | -              | $V_{\rm SS}-0.3$ to $V_{\rm SS}+7.0$           | V             |
| Input voltage                 | V <sub>IN</sub>  | SWP            | $V_{\text{SS}} - 0.3$ to $V_{\text{DD}} + 0.3$ | V             |
| Output current                | I <sub>OUT</sub> | OUT            | ±1.0   | mA            |
| Output voltage                | V <sub>OUT</sub> | OUT            | $V_{\text{SS}} - 0.3$ to $V_{\text{DD}} + 0.3$ | V             |
| Operation ambient temperature | T <sub>opr</sub> | _              | -40 to +85                                     | °C            |
| Storage temperature           | T <sub>stg</sub> | _              | -40 to +125                                    | °C            |

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

# ■ Thermal Resistance Value

| Item  | Symbol        | Condition |         | Min. | Тур. | Max. | Unit |
|---|---------------|-----------|---------|------|------|------|------|
|   |               |           | Board A | -    | 300  | -    | °C/W |
|   |               |           | Board B | -    | 242  | -    | °C/W |
| Junction-to-ambient thermal<br>resistance <sup>*1</sup> | $\theta_{JA}$ | SNT-4A    | Board C | -    | -    | -    | °C/W |
| resistance  |               |           | Board D | -    | -    | -    | °C/W |
|   |               |           | Board E | -    | -    | -    | °C/W |

Table 5

\*1. Test environment: Compliant with JEDEC STANDARD JESD51-2A

**Remark** Refer to "**■ Power Dissipation**" and "Test Board" for details.

# Table 4

## Electrical Characteristics

#### 1. S-5718Axxxx

#### Table 6

|                               |                    | (Ta =                      | +25°C, V <sub>DD</sub> = 1. | 8 V, V <sub>SS</sub> = ( | OV unless othe              | erwise s | pecified)       |
|-------------------------------|--------------------|----------------------------|-----------------------------|--------------------------|-----------------------------|----------|-----------------|
| Item                          | Symbol             | Condition                  | Min.                        | Тур.                     | Max.                        | Unit     | Test<br>Circuit |
| Power supply voltage          | V <sub>DD</sub>    | _                          | 1.45                        | 1.8                      | 3.6                         | V        | -               |
| Current consumption           | I <sub>DD</sub>    | Average value              | —                           | 1.4                      | 3.0                         | μA       | 1               |
| High level input voltage      | VIH                | _                          | $V_{\text{DD}} \times 0.85$ | I                        | V <sub>DD</sub>             | V        | 2               |
| Medium level input voltage    | VIM                | _                          | $V_{\text{DD}} \times 0.45$ | I                        | $V_{\text{DD}} \times 0.55$ | V        | 2               |
| Low level input voltage       | VIL                | _                          | V <sub>SS</sub>             | I                        | $V_{\text{DD}} \times 0.15$ | V        | 2               |
| High level output voltage     | V <sub>OH</sub>    | I <sub>OUT</sub> = -0.5 mA | $V_{\text{DD}}-0.4$         | I                        | _                           | V        | 3               |
| Low level output voltage      | Vol                | I <sub>OUT</sub> = 0.5 mA  | _                           | I                        | 0.4                         | V        | 4               |
| High level input current      | IIH                | Peak value                 | 9                           | 18                       | 36                          | μA       | 5               |
| Low level input current       | IIL                | Peak value                 | -36                         | -18                      | -9                          | μA       | 6               |
| Awake mode time               | t <sub>AW</sub>    | -                          | _                           | 0.1                      | -                           | ms       | -               |
| Sleep mode time               | ts∟                | _                          | _                           | 102.0                    | _                           | ms       | -               |
| Operating cycle               | t <sub>CYCLE</sub> | $t_{AW} + t_{SL}$          | _                           | 102.1                    | 200.0                       | ms       | _               |
| Detection pole switching time | t <sub>SWP</sub>   | _                          | _                           | 102.1                    | 400.0                       | ms       | -               |

#### 2. S-5718Bxxxx

#### Table 7

|                               |                    | (Ta =                      | +25°C, V <sub>DD</sub> = 1. | 8 V, V <sub>SS</sub> = ( | ) V unless othe             | erwise s | pecified)       |
|-------------------------------|--------------------|----------------------------|-----------------------------|--------------------------|-----------------------------|----------|-----------------|
| Item                          | Symbol             | Condition                  | Min.                        | Тур.                     | Max.                        | Unit     | Test<br>Circuit |
| Power supply voltage          | V <sub>DD</sub>    | _                          | 1.45                        | 1.8                      | 3.6                         | V        | _               |
| Current consumption           | I <sub>DD</sub>    | Average value              | _                           | 2.0                      | 4.0                         | μA       | 1               |
| High level input voltage      | VIH                | _                          | $V_{\text{DD}} \times 0.85$ | _                        | V <sub>DD</sub>             | V        | 2               |
| Medium level input voltage    | VIM                | _                          | $V_{\text{DD}} \times 0.45$ | _                        | $V_{\text{DD}} \times 0.55$ | V        | 2               |
| Low level input voltage       | VIL                | _                          | V <sub>SS</sub>             | _                        | $V_{\text{DD}} \times 0.15$ | V        | 2               |
| High level output voltage     | V <sub>OH</sub>    | I <sub>OUT</sub> = -0.5 mA | $V_{\text{DD}}-0.4$         | _                        | _                           | V        | 3               |
| Low level output voltage      | V <sub>OL</sub>    | I <sub>OUT</sub> = 0.5 mA  | _                           | _                        | 0.4                         | V        | 4               |
| High level input current      | IIH                | Peak value                 | 9                           | 18                       | 36                          | μA       | 5               |
| Low level input current       | IIL                | Peak value                 | -36                         | -18                      | -9                          | μA       | 6               |
| Awake mode time               | t <sub>AW</sub>    | _                          | -                           | 0.1                      | _                           | ms       | _               |
| Sleep mode time               | t <sub>SL</sub>    | -                          | _                           | 50.4                     | _                           | ms       | _               |
| Operating cycle               | t <sub>CYCLE</sub> | $t_{AW} + t_{SL}$          | _                           | 50.5                     | 100.0                       | ms       | _               |
| Detection pole switching time | t <sub>SWP</sub>   | _                          | _                           | 50.5                     | 200.0                       | ms       | _               |

# LOW VOLTAGE OPERATION OMNIPOLAR/UNIPOLAR DETECTION TYPE HALL EFFECT SWITCH IC WITH SWITCHABLE DETECTION POLE FUNCTION Rev.1.1\_01 S-5718 Series

#### 3. S-5718Cxxxx

#### Table 8

|                               |                  | (Ta =                      | +25°C, V <sub>DD</sub> = 1. | 8 V, V <sub>SS</sub> = ( | OV unless othe              | erwise s | specified)      |
|-------------------------------|------------------|----------------------------|-----------------------------|--------------------------|-----------------------------|----------|-----------------|
| Item                          | Symbol           | Condition                  | Min.                        | Тур.                     | Max.                        | Unit     | Test<br>Circuit |
| Device evently veltage        | N                | _                          | 1.45                        | 1.8                      | 3.6                         | V        | -               |
| Power supply voltage          | V <sub>DD</sub>  | S-5718CCSx0                | 1.6                         | 1.8                      | 3.6                         | V        | _               |
| Current consumption           | I <sub>DD</sub>  | Average value              | _                           | 12.0                     | 22.0                        | μA       | 1               |
| High level input voltage      | VIH              | _                          | $V_{\text{DD}} \times 0.85$ | I                        | V <sub>DD</sub>             | V        | 2               |
| Medium level input voltage    | VIM              | _                          | $V_{\text{DD}} \times 0.45$ | I                        | $V_{\text{DD}} \times 0.55$ | V        | 2               |
| Low level input voltage       | VIL              | _                          | V <sub>SS</sub>             | -                        | $V_{\text{DD}} \times 0.15$ | V        | 2               |
| High level output voltage     | V <sub>OH</sub>  | I <sub>OUT</sub> = -0.5 mA | $V_{\text{DD}}-0.4$         | -                        | _                           | V        | 3               |
| Low level output voltage      | V <sub>OL</sub>  | Ι <sub>ΟUT</sub> = 0.5 mA  | _                           | -                        | 0.4                         | V        | 4               |
| High level input current      | I <sub>IH</sub>  | Peak value                 | 9                           | 18                       | 36                          | μA       | 5               |
| Low level input current       | IIL              | Peak value                 | -36                         | -18                      | -9                          | μA       | 6               |
| Awake mode time               | t <sub>AW</sub>  | _                          | _                           | 0.1                      | _                           | ms       | _               |
| Sleep mode time               | t <sub>SL</sub>  | _                          | —                           | 5.6                      | _                           | ms       | _               |
| Operating cycle               | tCYCLE           | $t_{AW} + t_{SL}$          | _                           | 5.7                      | 12.0                        | ms       | _               |
| Detection pole switching time | t <sub>SWP</sub> | _                          | -                           | 5.7                      | 24.0                        | ms       | _               |

Table 9

# Magnetic Characteristics

#### 1. Product with $B_{OP}$ = 1.8 mT typ. ( $B_{HYS}$ = 0.7 mT typ.)

|                                |        |                   | (Ta = +25°C, 1   | V <sub>DD</sub> = 1.8 ' | V, V <sub>SS</sub> = 0 | V unless | otherwis | e specified)    |
|--------------------------------|--------|-------------------|--|-------------------------|------------------------|----------|----------|-----------------|
| Item                           |        | Symbol            | Condition  | Min.                    | Тур.                   | Max.     | Unit     | Test<br>Circuit |
| Operation paint*1              | S pole | BOPS              | SWP pin = $V_{IM}$ or $V_{IL}$                           | 0.6                     | 1.8                    | 3.0      | mT       | 7               |
| Operation point <sup>*1</sup>  | N pole | B <sub>OPN</sub>  | SWP pin = V <sub>IM</sub> or V <sub>IH</sub>             | -3.0                    | -1.8                   | -0.6     | mT       | 7               |
| Release point <sup>*2</sup>    | S pole | B <sub>RPS</sub>  | SWP pin = $V_{IM}$ or $V_{IL}$                           | 0.1                     | 1.1                    | 2.4      | mT       | 7               |
| Release point                  | N pole | B <sub>RPN</sub>  | SWP pin = V <sub>IM</sub> or V <sub>IH</sub>             | -2.4                    | -1.1                   | -0.1     | mT       | 7               |
| Hysteresis width <sup>*3</sup> | S pole | B <sub>HYSS</sub> | B <sub>HYSS</sub> = B <sub>OPS</sub> – B <sub>RPS</sub>  | _                       | 0.7                    | _        | mT       | 7               |
|                                | N pole | B <sub>HYSN</sub> | B <sub>HYSN</sub> =  B <sub>OPN</sub> - B <sub>RPN</sub> | _                       | 0.7                    | _        | mT       | 7               |

# 2. Product with $B_{OP}$ = 3.0 mT typ. ( $B_{HYS}$ = 0.8 mT typ.)

|                             |        |                   | Table 10  |                         |                        |          |          |                 |
|-----------------------------|--------|-------------------|---|-------------------------|------------------------|----------|----------|-----------------|
|                             |        |                   | (Ta = +25°C, Y  | V <sub>DD</sub> = 1.8 ' | V, V <sub>SS</sub> = 0 | V unless | otherwis | se specified)   |
| Item                        |        | Symbol            | Condition   | Min.                    | Тур.                   | Max.     | Unit     | Test<br>Circuit |
| Operation naint*1           | S pole | BOPS              | SWP pin = $V_{IM}$ or $V_{IL}$                          | 1.6                     | 3.0                    | 4.0      | mT       | 7               |
| Operation point*1           | N pole | B <sub>OPN</sub>  | SWP pin = V <sub>IM</sub> or V <sub>IH</sub>            | -4.0                    | -3.0                   | -1.6     | mT       | 7               |
| Deleges reint*2             | S pole | B <sub>RPS</sub>  | SWP pin = $V_{IM}$ or $V_{IL}$                          | 1.1                     | 2.2                    | 3.7      | mT       | 7               |
| Release point <sup>*2</sup> | N pole | B <sub>RPN</sub>  | SWP pin = V <sub>IM</sub> or V <sub>IH</sub>            | -3.7                    | -2.2                   | -1.1     | mT       | 7               |
|                             | S pole | B <sub>HYSS</sub> | B <sub>HYSS</sub> = B <sub>OPS</sub> – B <sub>RPS</sub> | -                       | 0.8                    | _        | mT       | 7               |
| Hysteresis width*3          | N pole | B <sub>HYSN</sub> | $B_{HYSN} =  B_{OPN} - B_{RPN} $                        | _                       | 0.8                    | _        | mT       | 7               |

# 3. Product with $B_{OP}$ = 3.0 mT typ. ( $B_{HYS}$ = 1.3 mT typ.)

|                               |        |                   | (Ta = +25°C,   | V <sub>DD</sub> = 1.8 | V, V <sub>SS</sub> = 0 | V unless | otherwis | se specified)   |
|-------------------------------|--------|-------------------|--|-----------------------|------------------------|----------|----------|-----------------|
| ltem                          |        | Symbol            | Condition  | Min.                  | Тур.                   | Max.     | Unit     | Test<br>Circuit |
| Operation point <sup>*1</sup> | S pole | B <sub>OPS</sub>  | SWP pin = $V_{IM}$ or $V_{IL}$                           | 1.6                   | 3.0                    | 4.0      | mT       | 7               |
|                               | N pole | B <sub>OPN</sub>  | SWP pin = V <sub>IM</sub> or V <sub>IH</sub>             | -4.0                  | -3.0                   | -1.6     | mT       | 7               |
| Release point <sup>*2</sup>   | S pole | B <sub>RPS</sub>  | SWP pin = $V_{IM}$ or $V_{IL}$                           | 0.5                   | 1.7                    | 2.8      | mT       | 7               |
|                               | N pole | B <sub>RPN</sub>  | SWP pin = V <sub>IM</sub> or V <sub>IH</sub>             | -2.8                  | -1.7                   | -0.5     | mT       | 7               |
| Hysteresis width*3            | S pole | B <sub>HYSS</sub> | B <sub>HYSS</sub> = B <sub>OPS</sub> – B <sub>RPS</sub>  | _                     | 1.3                    | -        | mT       | 7               |
|                               | N pole | B <sub>HYSN</sub> | B <sub>HYSN</sub> =  B <sub>OPN</sub> - B <sub>RPN</sub> | -                     | 1.3                    | _        | mT       | 7               |

Table 11

#### 4. Product with $B_{OP}$ = 4.5 mT typ. ( $B_{HYS}$ = 1.0 mT typ.)

Table 12

|                                |        |                   | (Ta = +25°C, 1  | V <sub>DD</sub> = 1.8 ' | V, V <sub>SS</sub> = 0 | V unless | otherwis | se specified)   |
|--------------------------------|--------|-------------------|---|-------------------------|------------------------|----------|----------|-----------------|
| Item                           |        | Symbol            | Condition   | Min.                    | Тур.                   | Max.     | Unit     | Test<br>Circuit |
| Operation point*1              | S pole | B <sub>OPS</sub>  | SWP pin = $V_{IM}$ or $V_{IL}$                          | 2.5                     | 4.5                    | 6.0      | mT       | 7               |
|                                | N pole | B <sub>OPN</sub>  | SWP pin = $V_{IM}$ or $V_{IH}$                          | -6.0                    | -4.5                   | -2.5     | mT       | 7               |
| Release point <sup>*2</sup>    | S pole | B <sub>RPS</sub>  | SWP pin = $V_{IM}$ or $V_{IL}$                          | 2.0                     | 3.5                    | 5.5      | mT       | 7               |
|                                | N pole | B <sub>RPN</sub>  | SWP pin = $V_{IM}$ or $V_{IH}$                          | -5.5                    | -3.5                   | -2.0     | mT       | 7               |
| Hysteresis width <sup>*3</sup> | S pole | B <sub>HYSS</sub> | B <sub>HYSS</sub> = B <sub>OPS</sub> – B <sub>RPS</sub> | -                       | 1.0                    | _        | mT       | 7               |
|                                | N pole | B <sub>HYSN</sub> | $B_{HYSN} =  B_{OPN} - B_{RPN} $                        | -                       | 1.0                    | _        | mT       | 7               |

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|                               |        |                  | Table 13                                     |                       |                        |          |          |                 |
|-------------------------------|--------|------------------|--|-----------------------|------------------------|----------|----------|-----------------|
|                               |        |                  | (Ta = +25°C, 1                               | V <sub>DD</sub> = 1.8 | V, V <sub>SS</sub> = 0 | V unless | otherwis | se specified)   |
| Item                          |        | Symbol           | Condition                                    | Min.                  | Тур.                   | Max.     | Unit     | Test<br>Circuit |
| Operation paint*1             | S pole | B <sub>OPS</sub> | SWP pin = V <sub>IM</sub> or V <sub>IL</sub> | 2.5                   | 4.5                    | 6.0      | mT       | 7               |
| Operation point <sup>*1</sup> | N pole | B <sub>OPN</sub> | SWP pin = V <sub>IM</sub> or V <sub>IH</sub> | -6.0                  | -4.5                   | -2.5     | mT       | 7               |
| Release point <sup>*2</sup>   | S pole | B <sub>RPS</sub> | SWP pin = $V_{IM}$ or $V_{IL}$               | 0.8                   | 2.0                    | 3.5      | mT       | 7               |
|                               | N pole | B <sub>RPN</sub> | SWP pin = V <sub>IM</sub> or V <sub>IH</sub> | -3.5                  | -2.0                   | -0.8     | mT       | 7               |

B<sub>HYSS</sub> = B<sub>OPS</sub> - B<sub>RPS</sub>

 $B_{HYSN} = |B_{OPN} - B_{RPN}|$ 

#### 5. Product with $B_{OP}$ = 4.5 mT typ. ( $B_{HYS}$ = 2.5 mT typ.)

S pole

N pole

B<sub>HYSS</sub>

B<sub>HYSN</sub>

\*1. BOPN, BOPS: Operation points

Hysteresis width\*3

BOPN and BOPS are the values of magnetic flux density when the output voltage (VOUT) changes after the magnetic flux density applied to this IC by the magnet (N pole or S pole) is increased (by moving the magnet closer). Even when the magnetic flux density exceeds B<sub>OPN</sub> or B<sub>OPS</sub>, V<sub>OUT</sub> retains the status.

2.5

2.5

- \*2. B<sub>RPN</sub>, B<sub>RPS</sub>: Release points B<sub>RPN</sub> and B<sub>RPS</sub> are the values of magnetic flux density when the output voltage (V<sub>OUT</sub>) changes after the magnetic flux density applied to this IC by the magnet (N pole or S pole) is decreased (the magnet is moved further away). Even when the magnetic flux density falls below B<sub>RPN</sub> or B<sub>RPS</sub>, V<sub>OUT</sub> retains the status.
- \*3. B<sub>HYSN</sub>, B<sub>HYSS</sub>: Hysteresis widths B<sub>HYSN</sub> and B<sub>HYSS</sub> are the difference of magnetic flux density between B<sub>OPN</sub> and B<sub>RPN</sub>, and B<sub>OPS</sub> and B<sub>RPS</sub>, respectively.

**Remark** The unit of magnetic flux density mT can be converted by using the formula 1 mT = 10 Gauss.

7

7

тT

mΤ

# Test Circuits

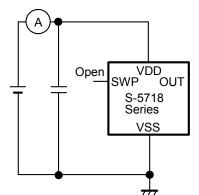


Figure 3 Test Circuit 1

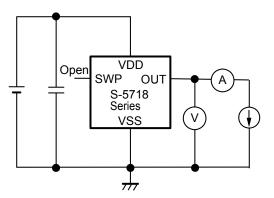


Figure 5 Test Circuit 3

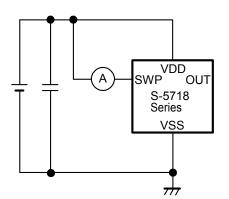


Figure 7 Test Circuit 5

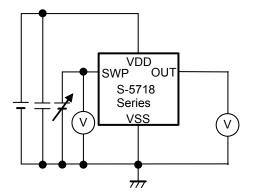


Figure 4 Test Circuit 2

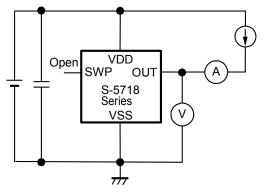


Figure 6 Test Circuit 4

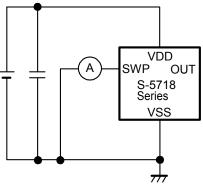


Figure 8 Test Circuit 6

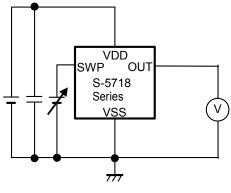
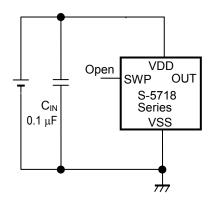


Figure 9 Test Circuit 7

# Standard Circuits

1. Omnipolar detection operation (SWP pin = Open)





 N pole detection operation (SWP pin = V<sub>DD</sub>)

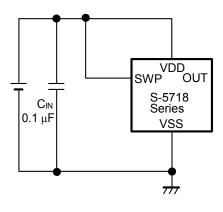
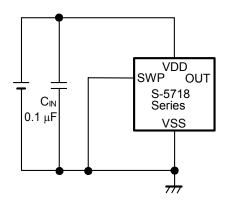


Figure 12

2. S pole detection operation (SWP pin =  $V_{SS}$ )





4. Detection pole switching operation (SWP pin = Open / V<sub>SS</sub> / V<sub>DD</sub>)

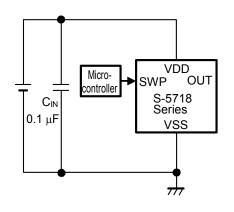


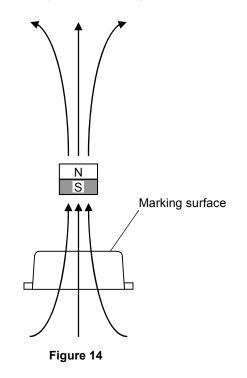
Figure 13

Caution The above connection diagrams and constants will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constant.

# Operation

#### 1. Direction of applied magnetic flux

This IC detects the magnetic flux density which is vertical to the marking surface. **Figure 14** shows the direction in which magnetic flux is being applied.



#### 2. Position of Hall sensor

Figure 15 shows the position of Hall sensor.

The center of this Hall sensor is located in the area indicated by a circle, which is in the center of a package as described below.

The following also shows the distance (typ. value) between the marking surface and the chip surface of a package.

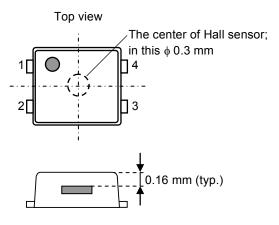


Figure 15

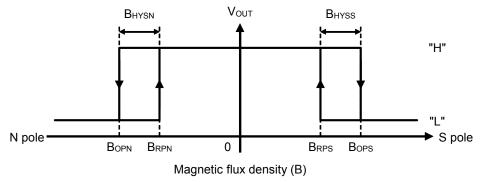
#### 3. Basic operation

This IC changes the output voltage ( $V_{OUT}$ ) according to the level of the magnetic flux density (N pole or S pole) applied by a magnet.

This IC can also switch the detection pole according to the SWP pin input voltage ( $V_{IN}$ ) status. The following explains the operation for active "L" products.

#### 3.1 When V<sub>IN</sub> is medium level input voltage (V<sub>IM</sub>)

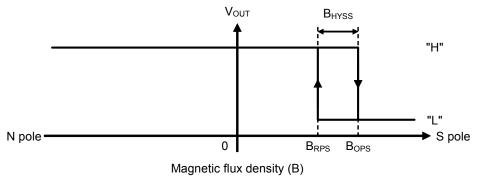
This IC performs omnipolar detection operation. Set the SWP pin to an open status or input  $V_{IM}$  to the SWP pin. If a capacitor with large capacitance is connected to the SWP pin when using the pin in the open status, steep changes in power supply voltage at power-on and during power supply fluctuations may cause erroneous N pole or S pole detection operation. For this reason, it is recommended that the SWP pin capacity be set to 100 pF or lower including parasitic capacitance.





#### 3. 2 When VIN is low level input voltage (VIL)

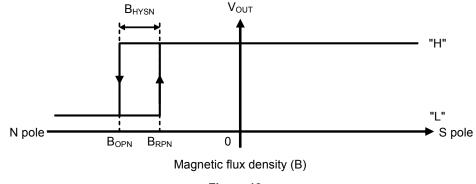
This IC performs S pole detection operation. Connect the SWP pin to VSS pin with a resistor having 10 k $\Omega$  or lower, or input V<sub>IL</sub> to the SWP pin.





#### 3.3 When $V_{IN}$ is high level input voltage ( $V_{IH}$ )

This IC performs N pole detection operation. Connect the SWP pin to VDD pin with a resistor having 10 k $\Omega$  or lower, or input V<sub>IH</sub> to the SWP pin.





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#### 4. Time dependency in the current consumption

This IC performs the intermittent operation, and operates at a low current consumption by repeating sleep mode and awake mode.

Figure 19 shows the time dependency in the current consumption.

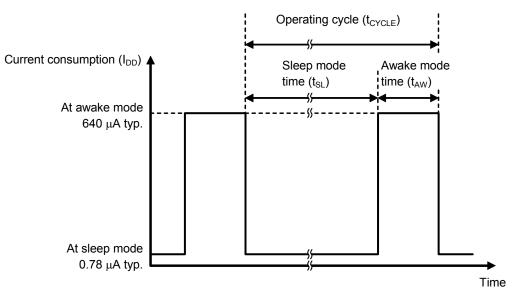


Figure 19

#### 5. Timing chart for magnetic flux density response

Figure 20 shows the operation timing chart for active "L" products.

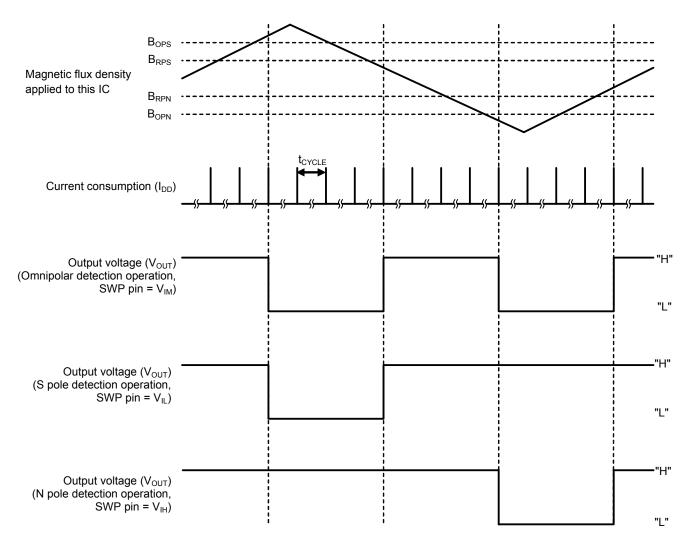


Figure 20

#### 6. Timing chart for detection pole switching

During awake mode time ( $t_{AW}$ ), this IC detects the SWP pin input voltage ( $V_{IN}$ ), and the detection pole switches when  $t_{AW}$  ends. **Figure 21** and **Figure 22** show the timing chart for switching from N pole detection to S pole detection when magnetic flux density (B) > B<sub>OPS</sub> in active "L" products.

When  $V_{IN}$  changes during sleep mode time ( $t_{SL}$ ) between  $t_{AW}<1>$  and  $t_{AW}<2>$  and does not change during  $t_{AW}<2>$ , this IC outputs the output voltage ( $V_{OUT}$ ) according to the detection pole when  $t_{AW}<2>$  ends.

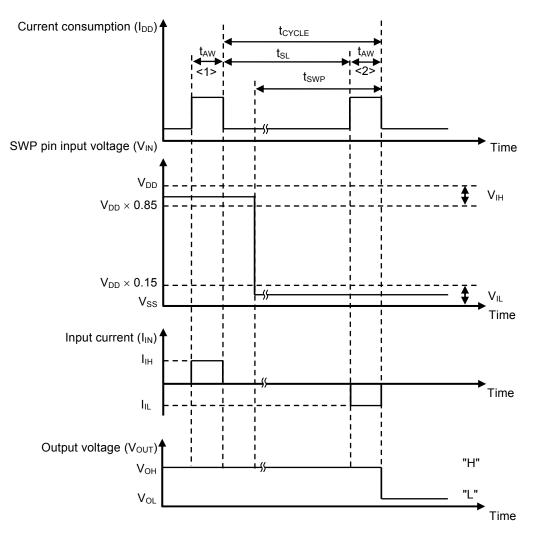


Figure 21 When  $V_{IN}$  does not Change during  $t_{AW}$ <2>

When  $V_{IN}$  changes during  $t_{AW}$ <2>, this IC may output  $V_{OUT}$  according to the detection pole when  $t_{AW}$ <1> ends. Refer to **Figure 21** for the operation of  $t_{AW}$ <3>.

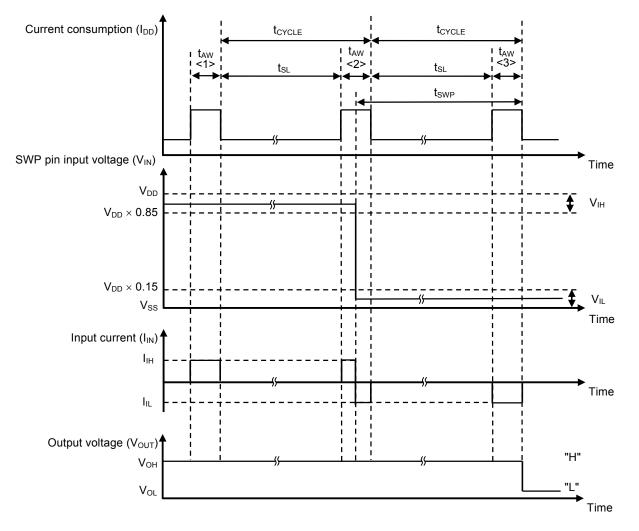


Figure 22 When  $V_{IN}$  Changes during  $t_{AW}$ <2>

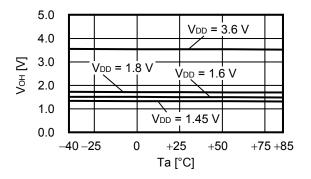
### Precautions

- If the impedance of the power supply is high, the IC may malfunction due to a supply voltage drop caused by feed-through current. Take care with the pattern wiring to ensure that the impedance of the power supply is low.
- Note that the IC may malfunction if the power supply voltage rapidly changes. When the IC is used under the environment where the power supply voltage rapidly changes, it is recommended to judge the output voltage of the IC by reading it multiple times.
- Note that the IC may malfunction in the following situations. When the OUT pin is shorted to VSS pin or VDD pin. When the OUT pin is affected by noise. When the intermediate potential is applied to the OUT pin.
- Do not apply an electrostatic discharge to this IC that exceeds the performance ratings of the built-in electrostatic protection circuit.
- Large stress on this IC may affect the magnetic characteristics. Avoid large stress which is caused by the handling during or after mounting the IC on a board.
- Note that the output voltage may change if the intermediate value of magnetic flux density between the operation point and release point is applied to this IC over a long time.
- ABLIC Inc. claims no responsibility for any disputes arising out of or in connection with any infringement by products including this IC of patents owned by a third party.

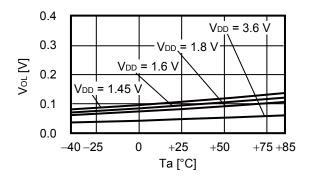
# ■ Characteristics (Typical Data)

#### 1. Output voltage

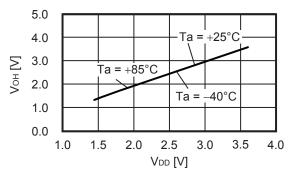
1.1 High level output voltage (V<sub>OH</sub>) vs. Temperature (Ta)



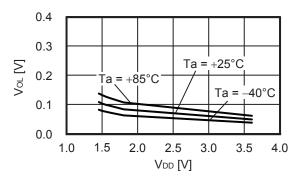
# 1.3 Low level output voltage (V<sub>OL</sub>) vs. Temperature (Ta)



1.2 High level output voltage (V<sub>OH</sub>) vs. Power supply voltage (V<sub>DD</sub>)



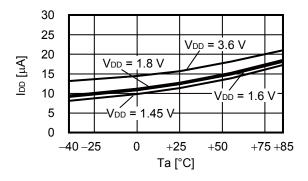
1.4 Low level output voltage (V<sub>OL</sub>) vs. Power supply voltage (V<sub>DD</sub>)



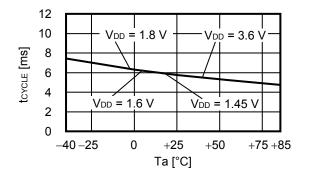
2. Current consumption, operating cycle

#### 2.1 S-5718Cxxxx

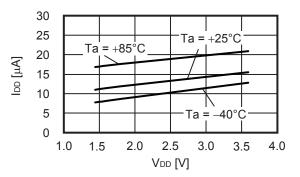
2. 1. 1 Current consumption (I<sub>DD</sub>) vs. Temperature (Ta)



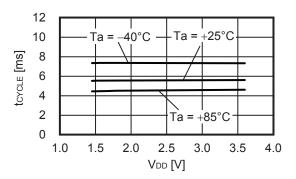




2. 1. 2 Current consumption (I<sub>DD</sub>) vs. Power supply voltage (V<sub>DD</sub>)



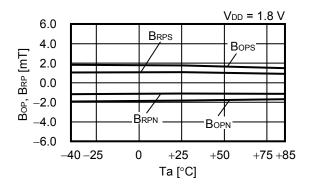
2. 1. 4 Operating cycle (t<sub>CYCLE</sub>) vs. Power supply voltage (V<sub>DD</sub>)



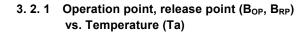
#### 3. Magnetic sensitivity

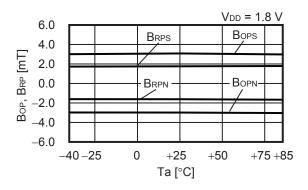
#### 3.1 S-5718xxSx0

3. 1. 1 Operation point, release point (B<sub>OP</sub>, B<sub>RP</sub>) vs. Temperature (Ta)

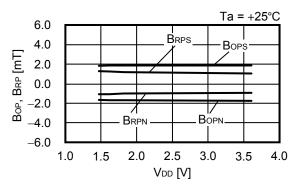


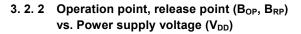
#### 3.2 S-5718xxWx1

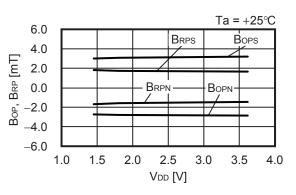




3. 1. 2 Operation point, release point (B<sub>OP</sub>, B<sub>RP</sub>) vs. Power supply voltage (V<sub>DD</sub>)

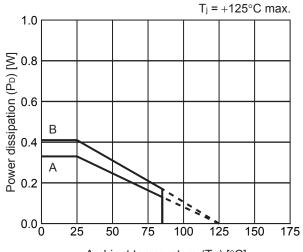






# Power Dissipation

#### SNT-4A



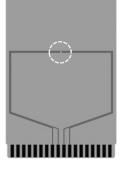
Ambient temperature (Ta) [°C]

| Board | Power Dissipation (P <sub>D</sub> ) |
|-------|-------------------------------------|
| А     | 0.33 W                              |
| В     | 0.41 W                              |
| С     | _                                   |
| D     | _                                   |
| E     | _                                   |

# **SNT-4A Test Board**

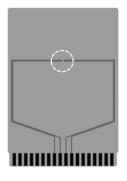
# (1) Board A

🔘 IC Mount Area



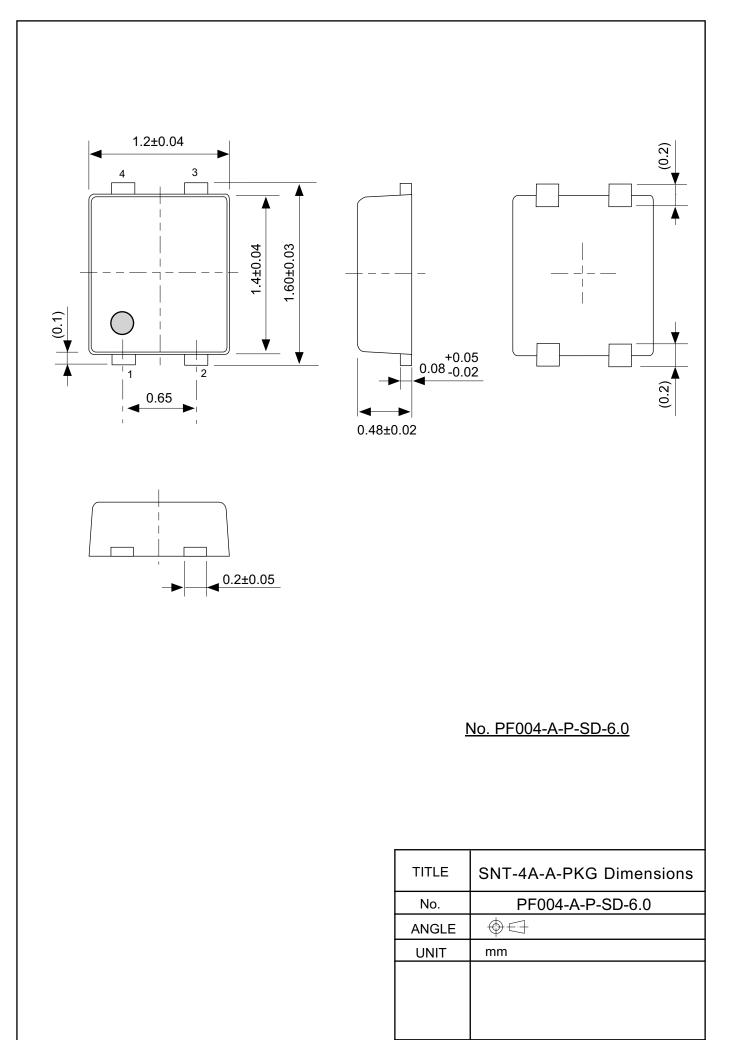
| Item                     |      | Specification                               |  |  |
|--------------------------|------|---|--|--|
| Size [mm]                |      | 114.3 x 76.2 x t1.6                         |  |  |
| Material                 |      | FR-4  |  |  |
| Number of copper foil la | ayer | 2   |  |  |
|                          | 1    | Land pattern and wiring for testing: t0.070 |  |  |
| Copper foil layer [mm]   | 2    | -   |  |  |
| Copper foil layer [mm]   | 3    | -   |  |  |
|                          | 4    | 74.2 x 74.2 x t0.070                        |  |  |
| Thermal via              |      | -   |  |  |

# (2) Board B

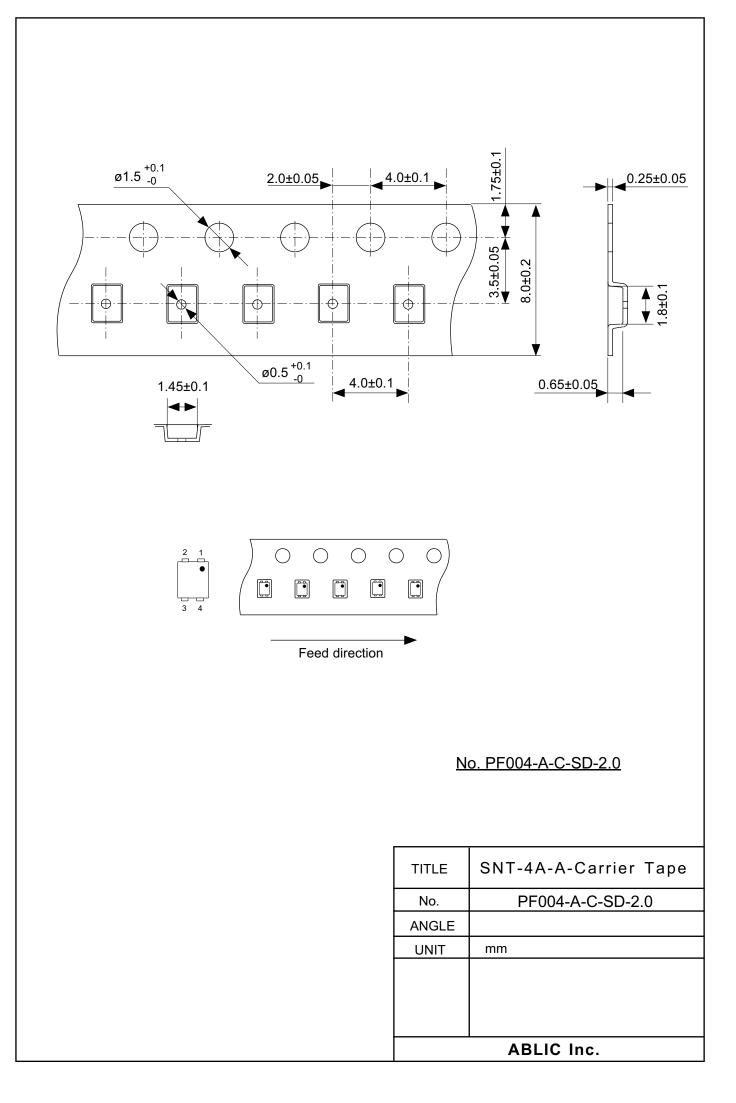


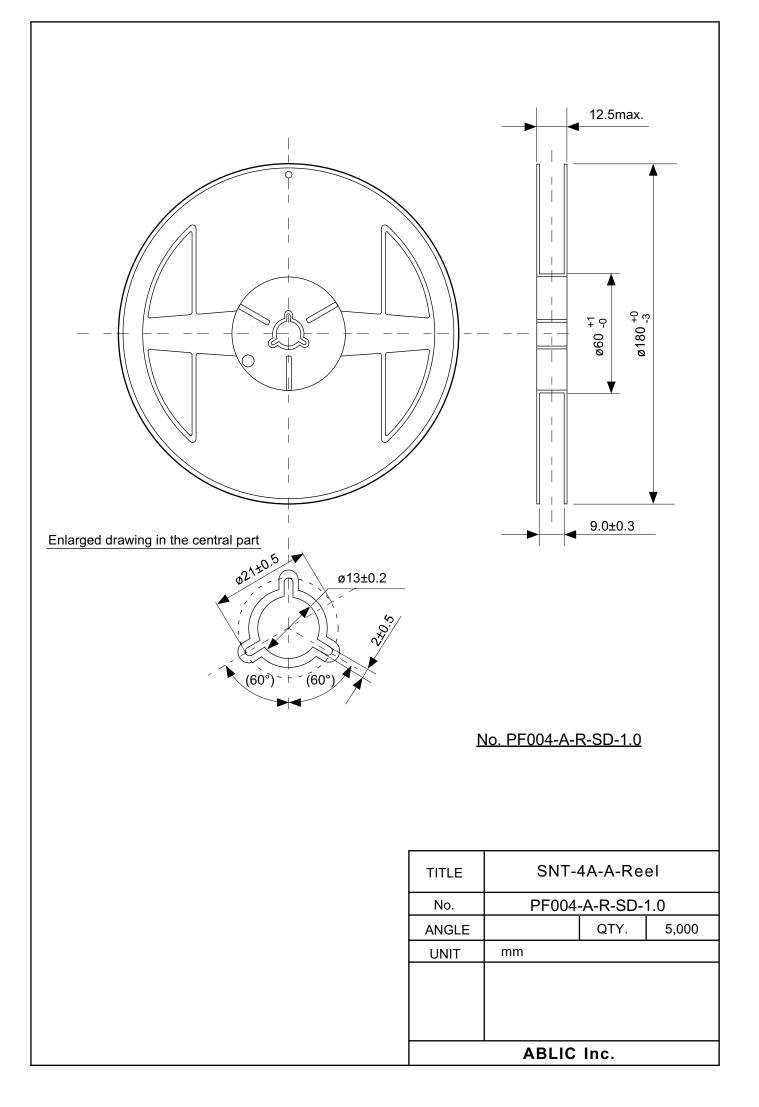
| Item                     |      | Specification                               |  |  |
|--------------------------|------|---|--|--|
| Size [mm]                |      | 114.3 x 76.2 x t1.6                         |  |  |
| Material                 |      | FR-4  |  |  |
| Number of copper foil la | ayer | 4   |  |  |
| Copper foil layer [mm]   | 1    | Land pattern and wiring for testing: t0.070 |  |  |
|                          | 2    | 74.2 x 74.2 x t0.035                        |  |  |
|                          | 3    | 74.2 x 74.2 x t0.035                        |  |  |
|                          | 4    | 74.2 x 74.2 x t0.070                        |  |  |
| Thermal via              |      | -   |  |  |

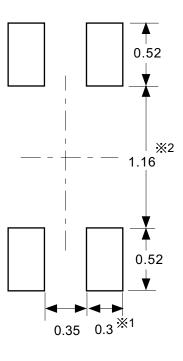
No. SNT4A-A-Board-SD-1.0



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※1. ランドパターンの幅に注意してください (0.25 mm min. / 0.30 mm typ.)。 ※2. パッケージ中央にランドパターンを広げないでください (1.10 mm ~ 1.20 mm)。

- 注意 1. パッケージのモールド樹脂下にシルク印刷やハンダ印刷などしないでください。
  - 2. パッケージ下の配線上のソルダーレジストなどの厚みをランドパターン表面から0.03 mm 以下にしてください。
  - 3. マスク開口サイズと開口位置はランドパターンと合わせてください。
  - 4. 詳細は "SNTパッケージ活用の手引き" を参照してください。

%1. Pay attention to the land pattern width (0.25 mm min. / 0.30 mm typ.).

%2. Do not widen the land pattern to the center of the package (1.10 mm to 1.20 mm).

Caution 1. Do not do silkscreen printing and solder printing under the mold resin of the package.

- 2. The thickness of the solder resist on the wire pattern under the package should be 0.03 mm or less from the land pattern surface.
  - 3. Match the mask aperture size and aperture position with the land pattern.
- 4. Refer to "SNT Package User's Guide" for details.
- ※1. 请注意焊盘模式的宽度 (0.25 mm min. / 0.30 mm typ.)。
- ※2. 请勿向封装中间扩展焊盘模式 (1.10 mm ~ 1.20 mm)。
- 注意 1. 请勿在树脂型封装的下面印刷丝网、焊锡。
  - 2. 在封装下、布线上的阻焊膜厚度 (从焊盘模式表面起) 请控制在 0.03 mm 以下。
  - 3. 钢网的开口尺寸和开口位置请与焊盘模式对齐。
  - 4. 详细内容请参阅 "SNT 封装的应用指南"。

| TITLE | SNT-4A-A<br>-Land Recommendation |  |  |  |  |
|-------|----------------------------------|--|--|--|--|
| No.   | PF004-A-L-SD-4.1                 |  |  |  |  |
| ANGLE |                                  |  |  |  |  |
| UNIT  | mm                               |  |  |  |  |
|       |                                  |  |  |  |  |
|       |                                  |  |  |  |  |
|       |                                  |  |  |  |  |
|       | ABLIC Inc.                       |  |  |  |  |

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The entire system in which the products are used must be sufficiently evaluated and judged whether the products are allowed to apply for the system on customer's own responsibility.

- 10. The products are not designed to be radiation-proof. The necessary radiation measures should be taken in the product design by the customer depending on the intended use.
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2.4-2019.07